

Jean Virieux after Anne Obermann

Part I: Seismic Refraction



Overview

- Introduction historical outline
- Chapter 1: Fundamental concepts
- Chapter 2: Data acquisition and material
- Chapter 3: Data interpretation

A: Geophysical Interpretation

B : Geological Interpretation

Overview

- Introduction historical outline
- Chapter 1: Fundamental concepts
- Chapter 2: Data acquisition and material
- Chapter 3: Data interpretation

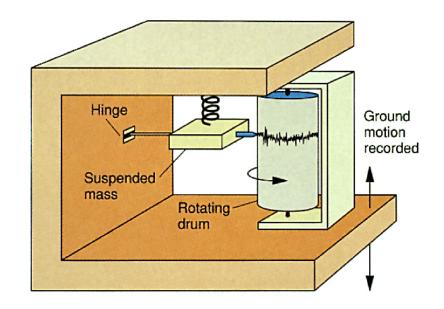
- 1885 all that was known about the Earth structure was a vague idea that the density inside had to be much greater than at the surface
- within 50 years an incredible amount more had been learned using seismology

Inertial principle

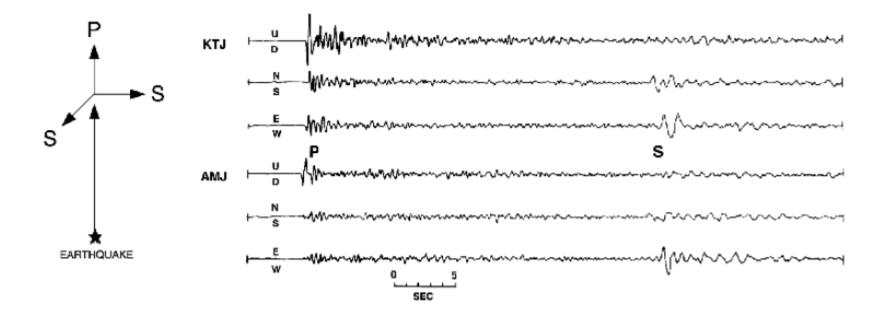
Breakthrough: Seismometer (late 1800')

Instrumental challenge: how to measure ground motion given that the seismometer sits on the ground?

Record very small ground motions on the order of 10-3 cm for distant earthquakes



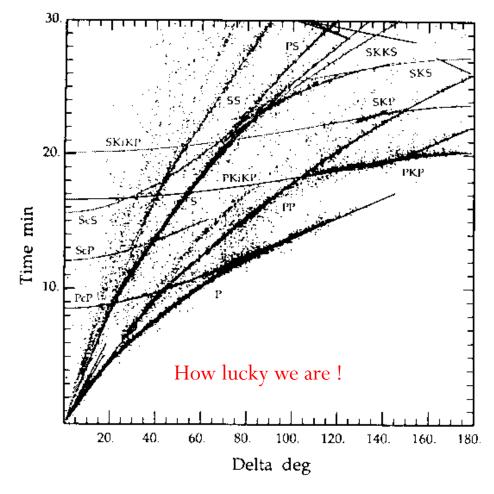
- Seismometers were developed to record vertical and horizontal motions.
- Precise timing, nowadays done using GPS (Global Positioning System) clocks so that records can be compared between stations. Data are now recorded digitally and made available on the web.



Wave packets: time separation

- More than 6000 arrival times of different phases coming from discontinuities inside the Earth.
- Building up velocity models which verify these propagation times

Modèle JB (2 sec shift)

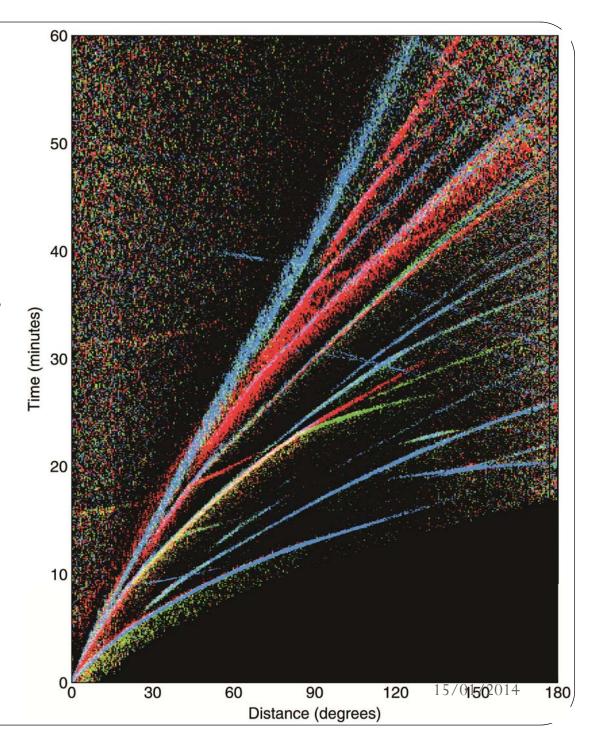


Advanced course

Wave packets: time separation

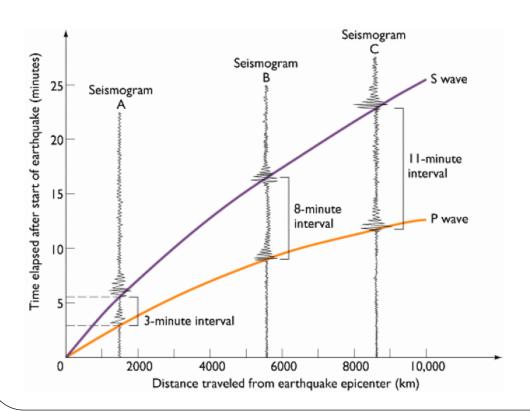
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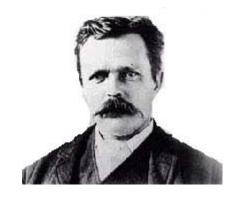
Modèle JB (2 sec shift)



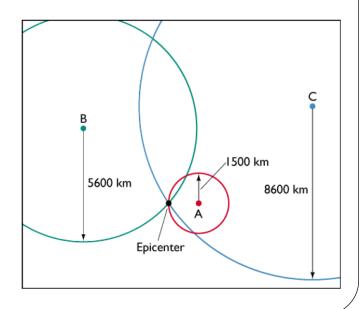
Advanced course

- In 1889, an earthquake in Japan was recorded successfully on several seismometers in Germany.
- Milne discovered that observations showed that the time separations between P and S wave arrivals increased with distance from the earthquake.

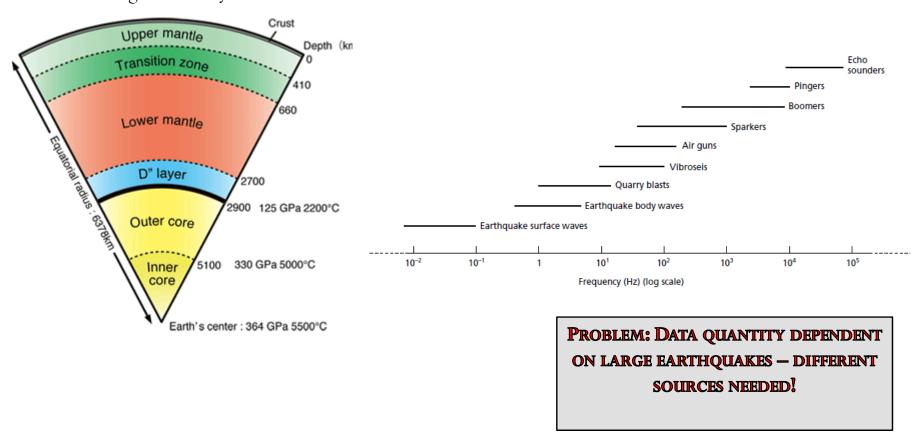




• Thus, the S-P time could be used to measure the distance to the earthquake.



- Next step: Infer the velocity structure of the Earth as a function of depth from the seismograms that were recorded from many different earthquakes (Inverse Problem).
- The simplest approach to the inverse problem treats the earth as flat layers of uniform velocity material. The basic geometry is a layer of thickness z, with velocity v1, overlying a halfspace with a higher velocity v2.









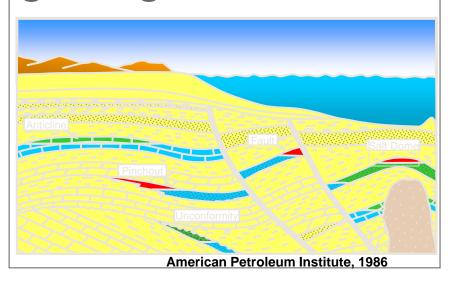


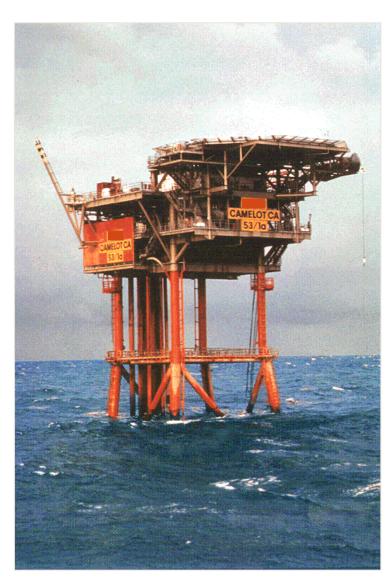
Industrial context: exploration

• Industry focus: Increase Production vs. find new reserves

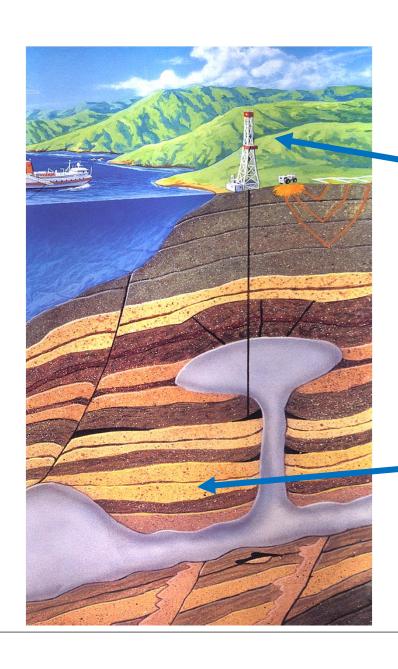


Improve the geological model



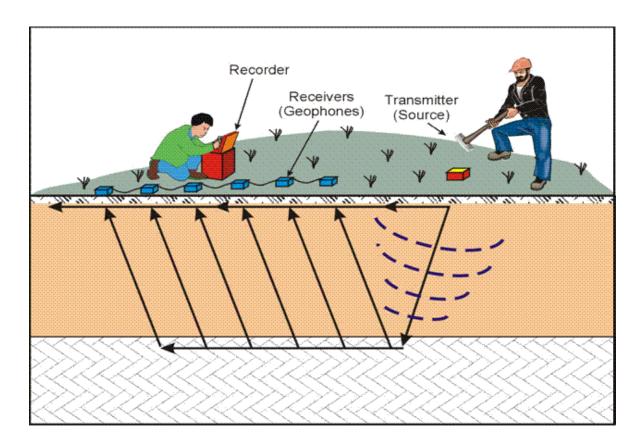


Context: Interpreting the Unseen

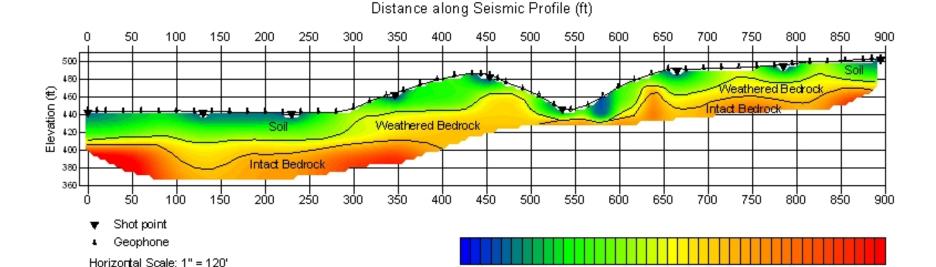


- Surface Geology
 - Aerial photos
 - Geologic maps
 - Out-crops

- Subsurface Studies
 - Gravity
 - Magnetics
 - Seismic reflection
 - Wells



- Set out a line or array of geophones
- Input a pulse of energy into the ground
- Record the arrival times to interpret the velocity structure



Seismic Velocity (ft/s)

Vertical Scale: 1" = 60"

Elevations surveyed from Control Point (elevation = 511')

Seismic methods and scales

- Controlled source seismology
 - allows higher resolution studies (m to 100s km)
- can carry out experiments away from tectonic regions
- source position and signal under control



- Global seismology (earthquakes)
 - provides information on global earth structure and large scale velocity anomalies (100s to 1000s km)
 - difficult to image smaller scale structure, particularly away from earthquake source regions
 - source and velocity structure imaging: difficult problem



Seismic methods and scales

• Seismic refraction

- Used to study large scale crustal layering: thickness and velocity

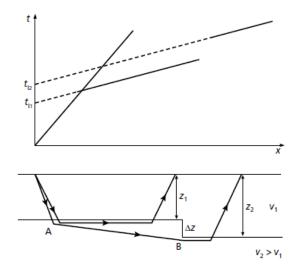


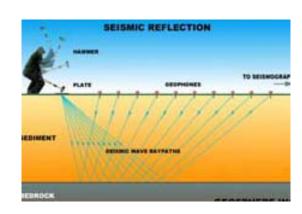
Fig. 5.7 Offset segments of the travel-time curve for refracted arrivals from opposite sides of a fault.

• Seismic reflection

- "Imaging" of subsurface reflectors
- Difficult to determine accurate velocities and depths
- (see courses given by R. Brossier (next week)!

Reflection

Refraction



Applications



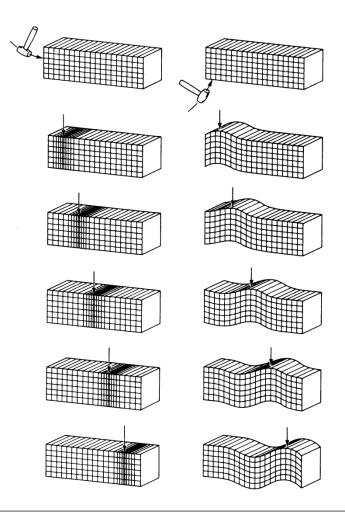


Overview

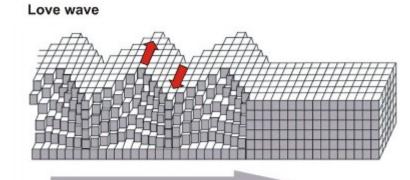
- Introduction historical outline
- Chapter 1: Fundamental concepts
 - Physical notions
 - Two-layered model
 - Special cases
- Chapter 2: Data acquisition and material
- Chapter 3: Data interpretation

Different waves

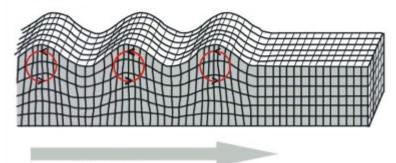
P (compression) + S (shear) waves



Surface waves





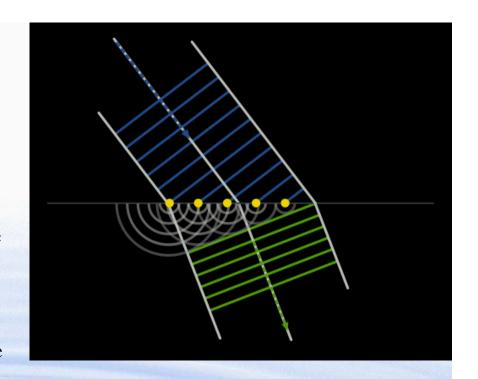


Direction of wave propagation

Huygens Principle

Each point along a material acts like a point source of waves.

Waves have circular (spherical) wave fronts, these interact constructively (destructively) and produce the wave fronts that we plot as rays.



Snell's Law

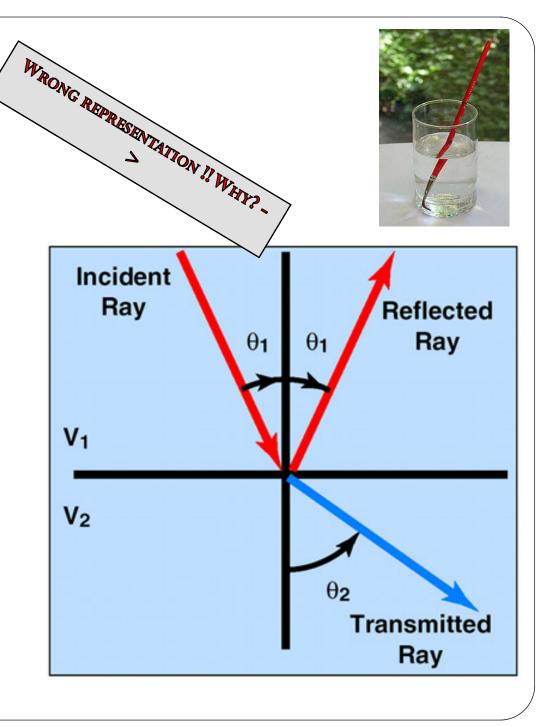
Seismic rays obey Snell's law

The angle of incidence equals the angle of reflection.

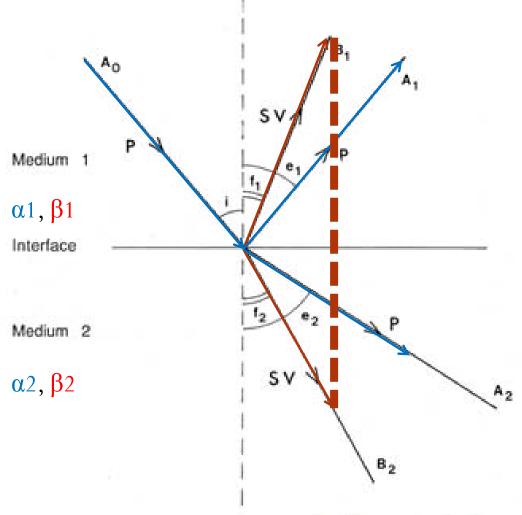
The angle of transmission is related to the angle of incidence through the velocity ratio.

$$\frac{\sin(\theta 1)}{v1} = \frac{\sin(\theta 2)}{v2}$$

Note: the transmitted energy is refracted



Snell's law: S wave conversion

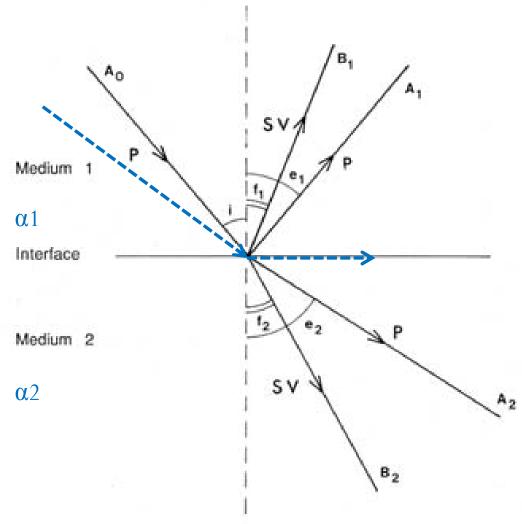


A conversion from P to S or vice versa can also occur. Still, the angles are determined by the velocity ratios.

p is the ray parameter and is constant along each ray.

$$\frac{\sin{(\mathrm{i})}}{\alpha 1} = \frac{\sin{(\mathrm{e}1)}}{\alpha 1} = \frac{\sin{(\mathrm{e}2)}}{\alpha 2} = \frac{\sin{(\mathrm{f}1)}}{\beta 1} = \frac{\sin{(\mathrm{f}2)}}{\beta 2} = p$$

Snell's law: Critical Incidence



$$\frac{\sin(i)}{\alpha 1} = \frac{\sin(e2)}{\alpha 2}$$

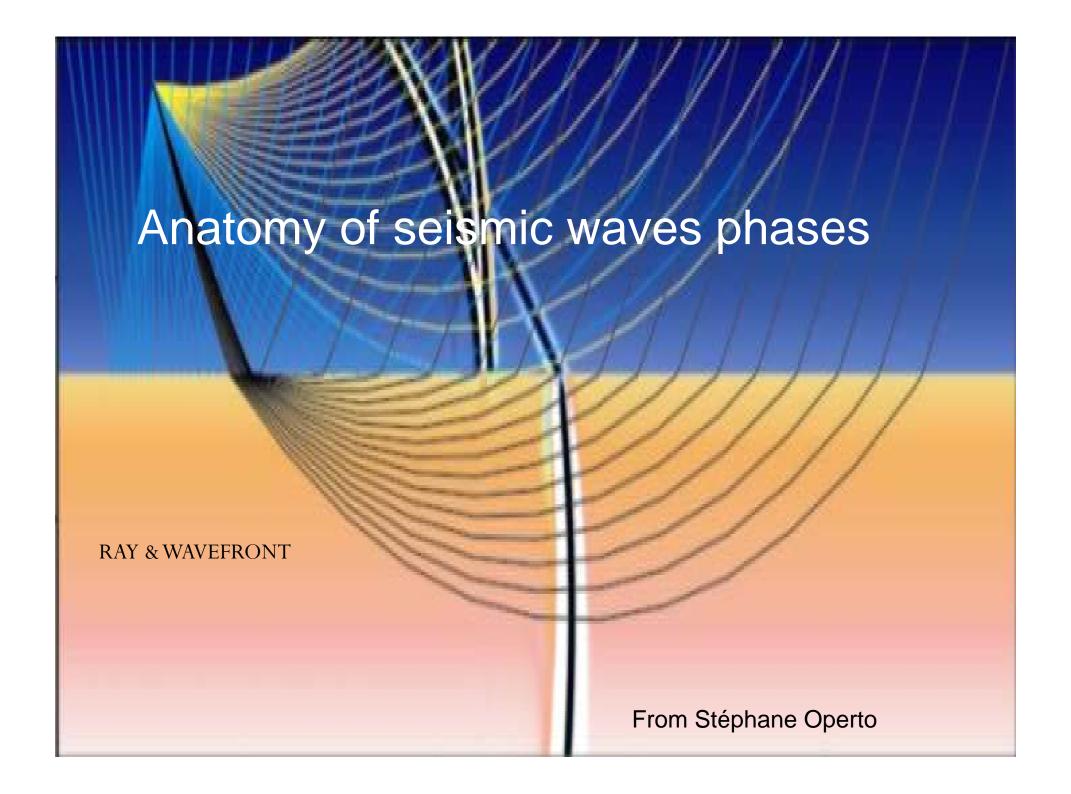
when $\alpha 2 > \alpha 1$, $e^2 > i$ =>we can increase iP until $e^2 = 90^\circ$

when e2=90 $^{\circ}$, i=ic the critical angle

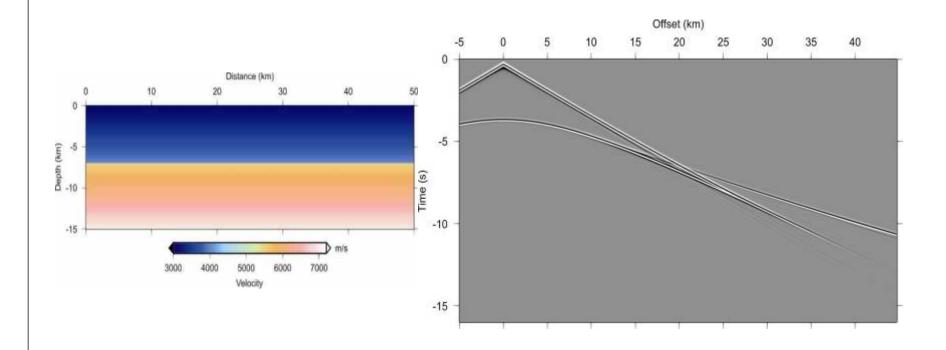
$$\sin(ic) = \frac{\alpha 1}{\alpha 2}$$

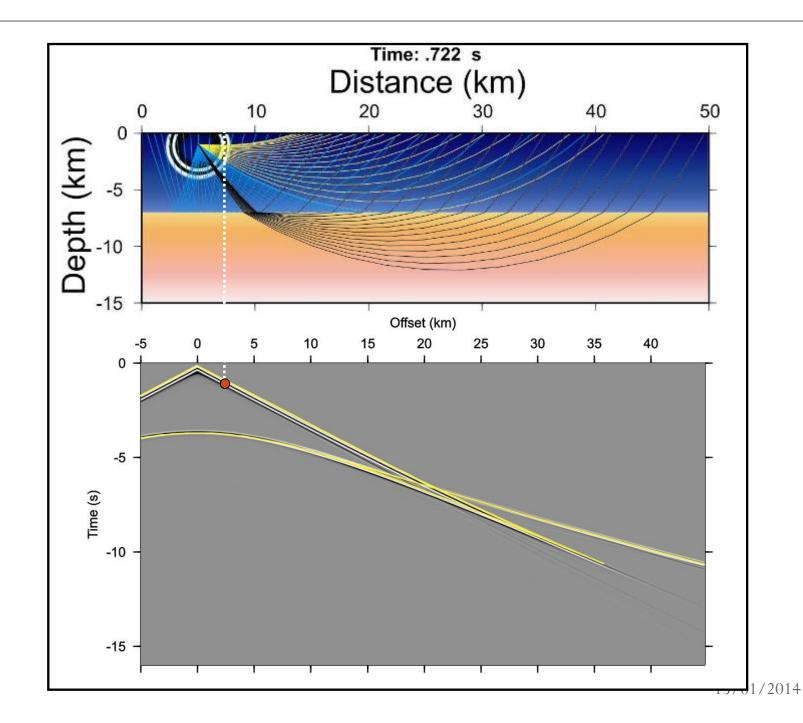
The critically refracted energy travels along the velocity interface at $\alpha 2$ continually refracting energy back into the upper medium at an angle ic.

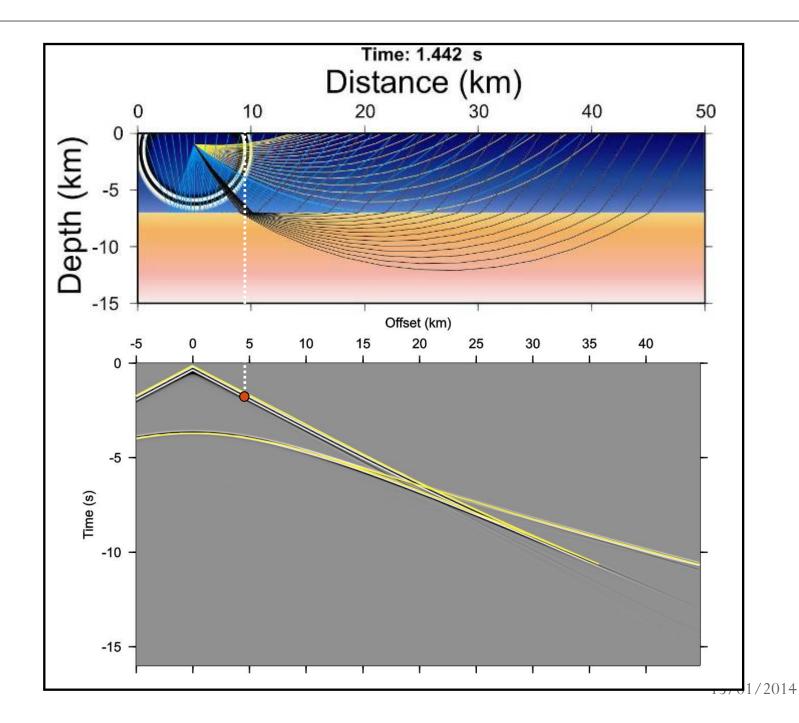
Head wave

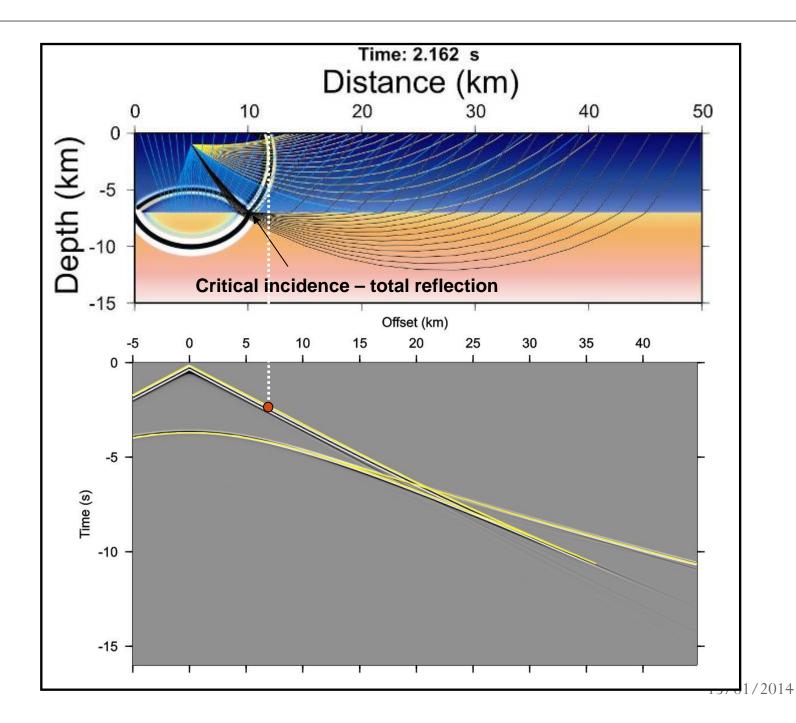


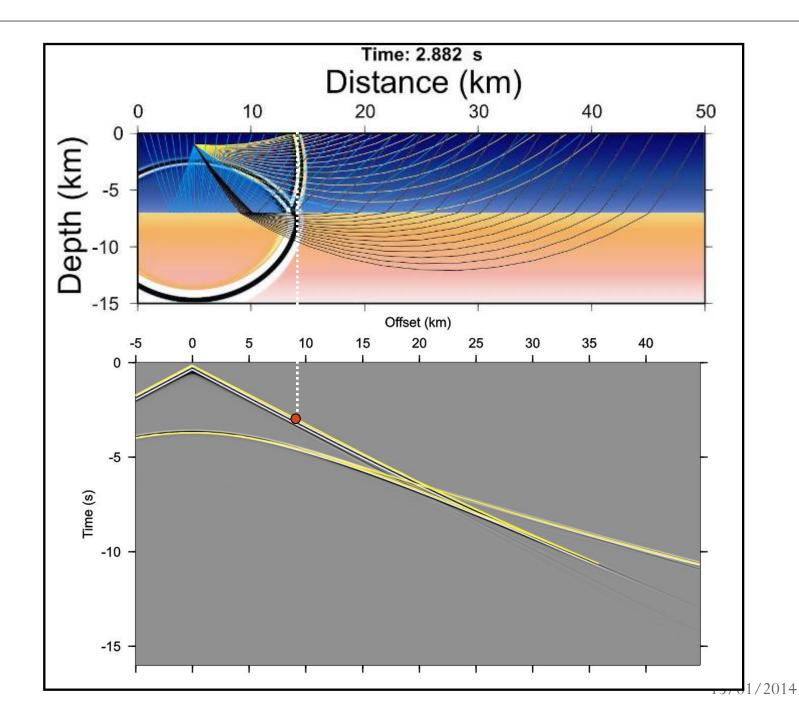
Anatomy of global-offset seismograms: Continuous sampling of apertures from transmission to reflection

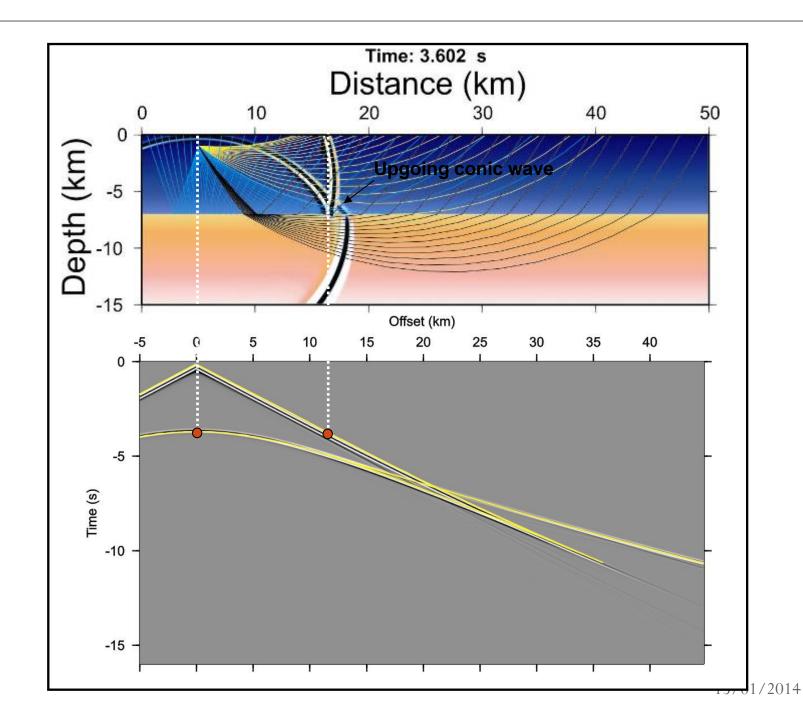


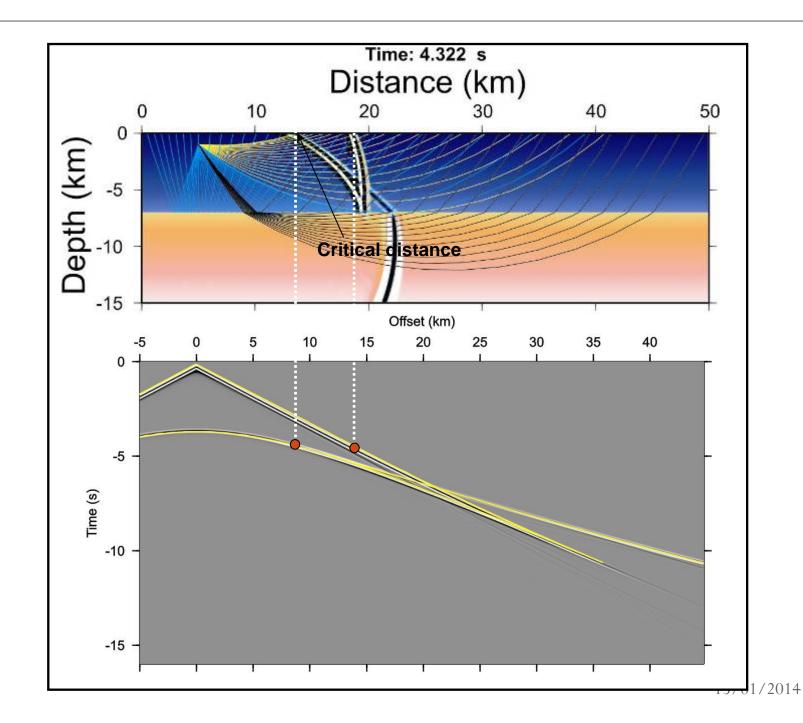


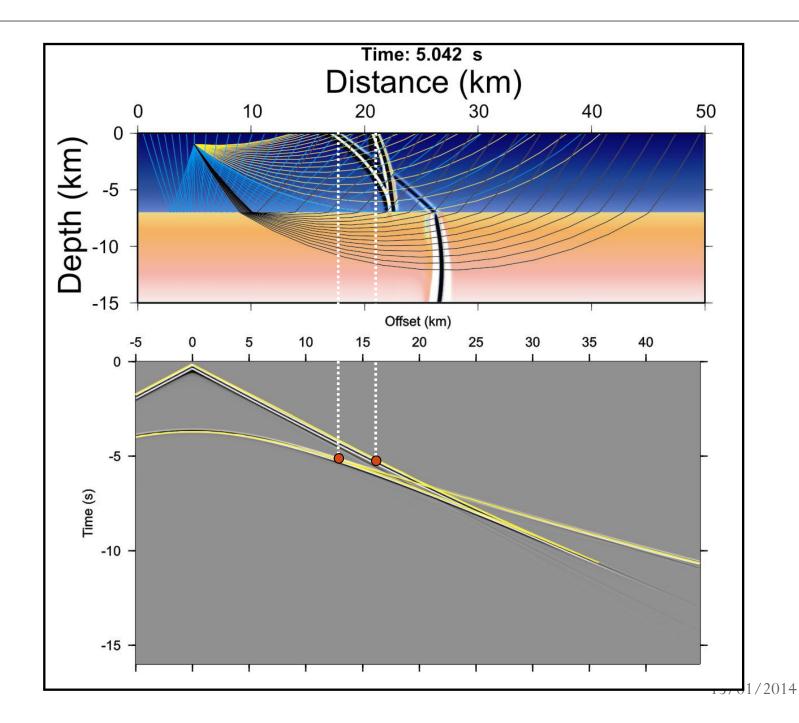


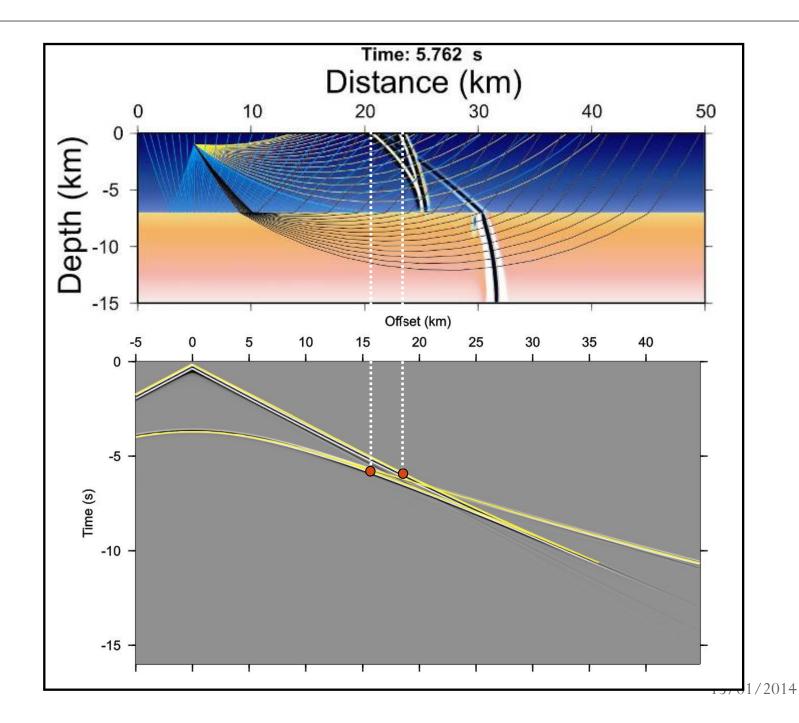


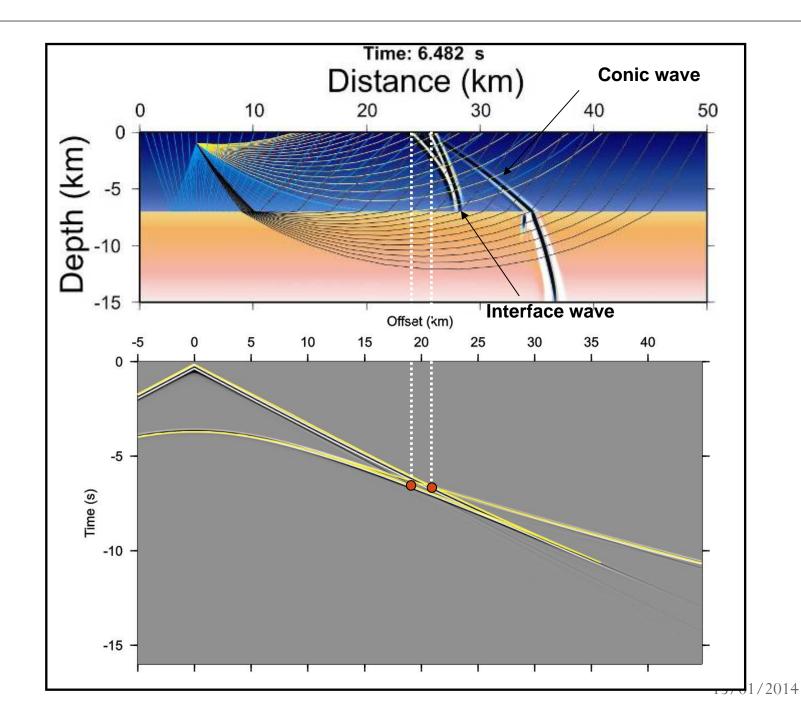


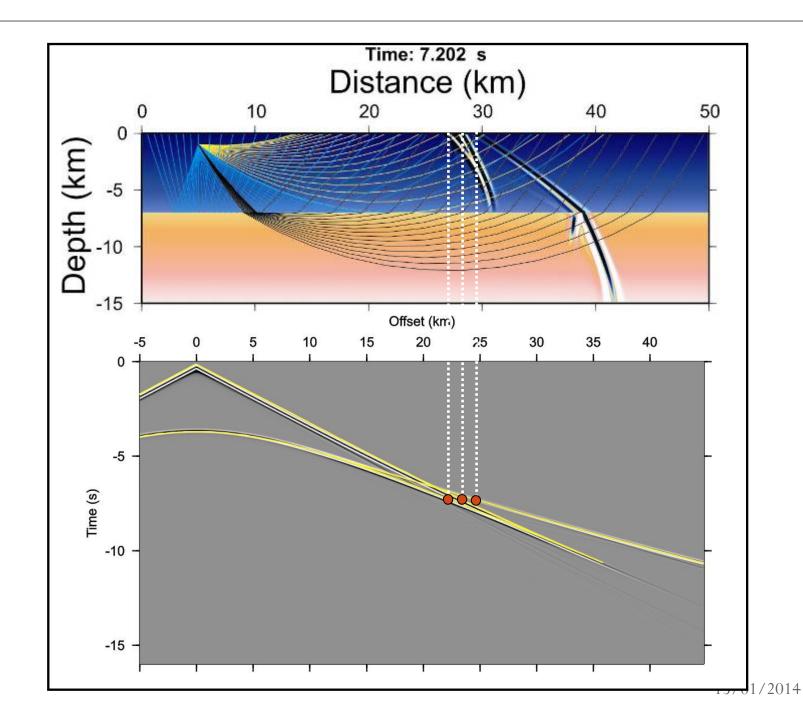


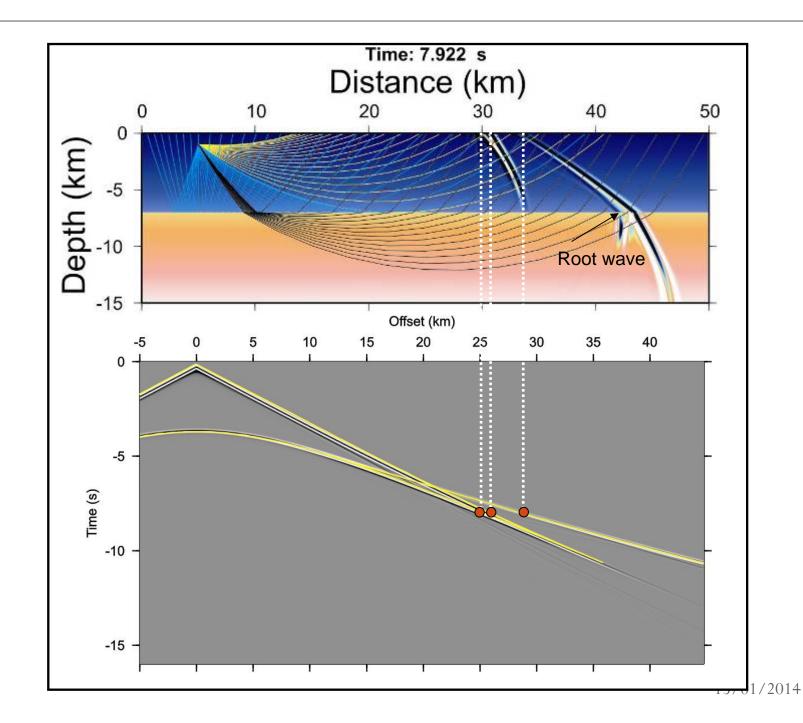


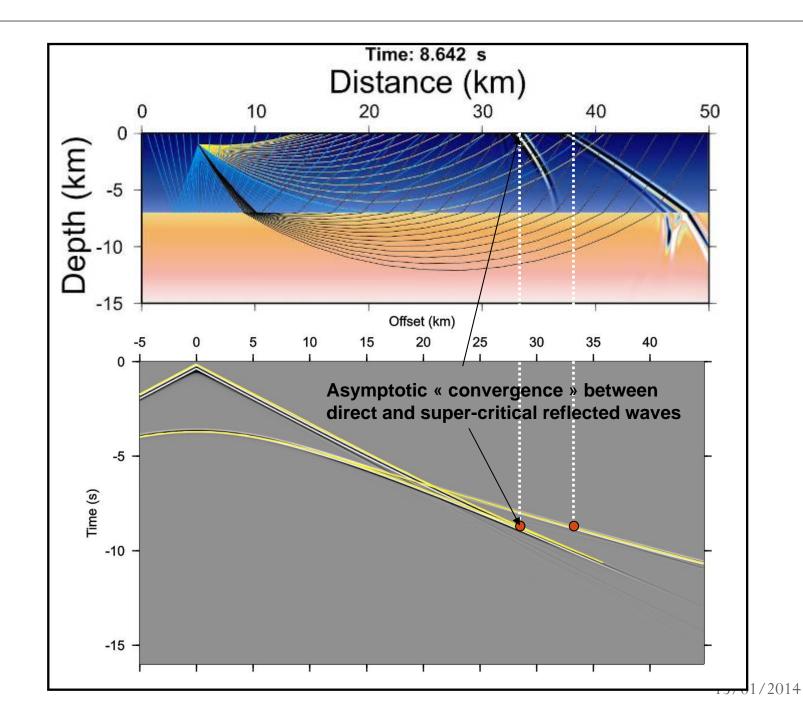


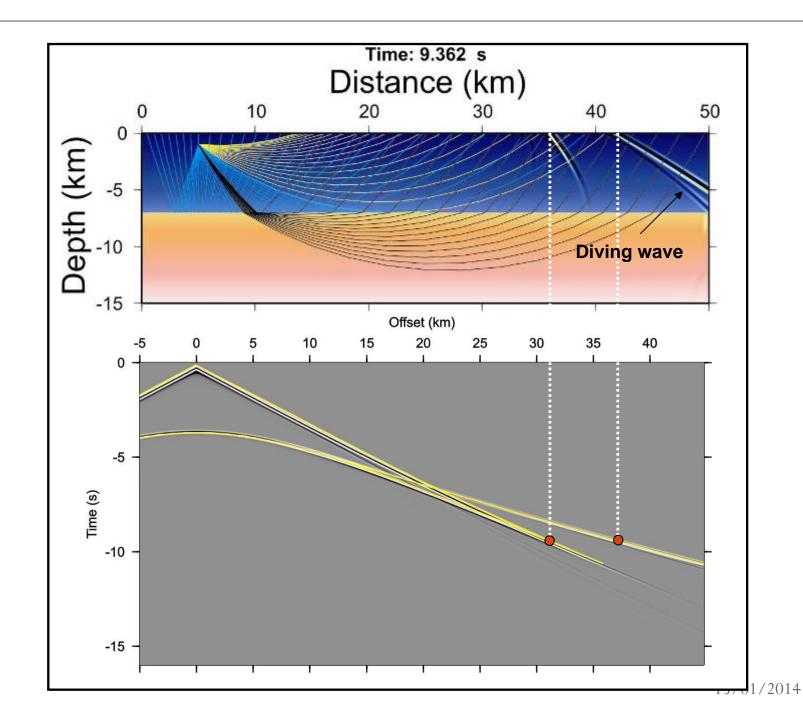




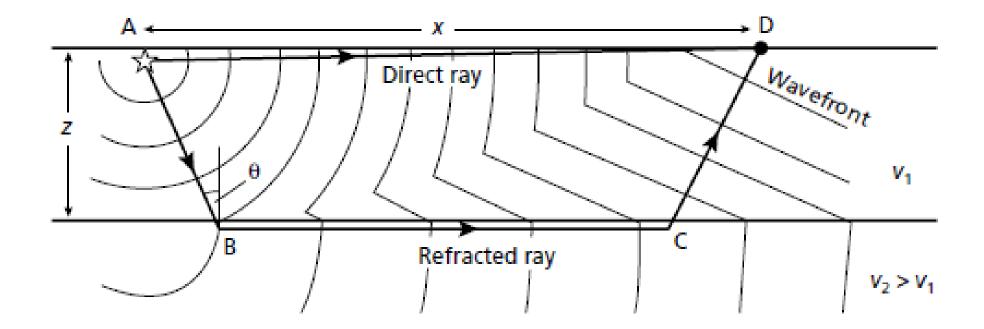






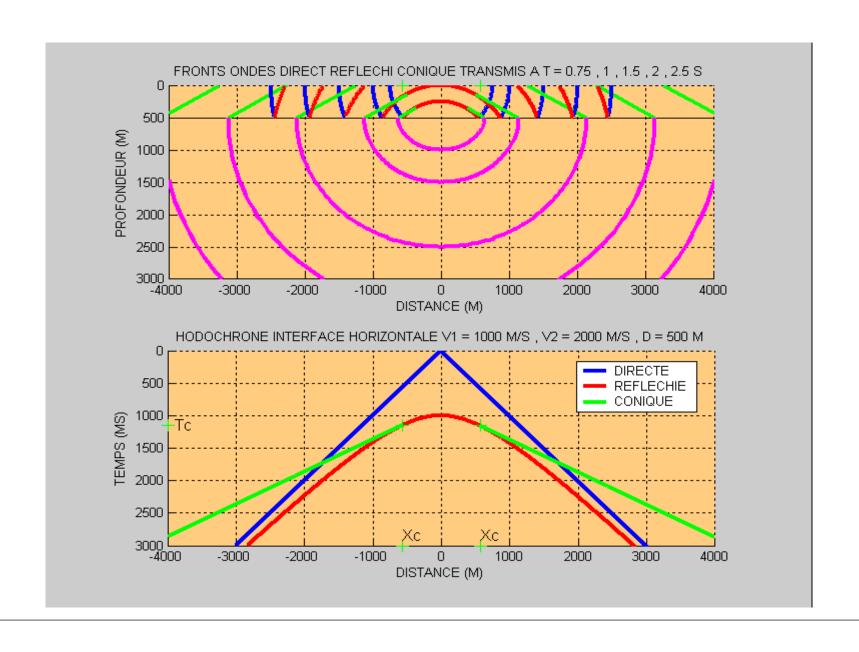


Rays and Wavefronts

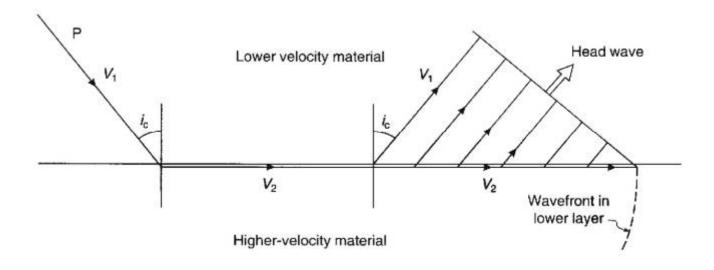


Reflections have been omitted in this cartoon

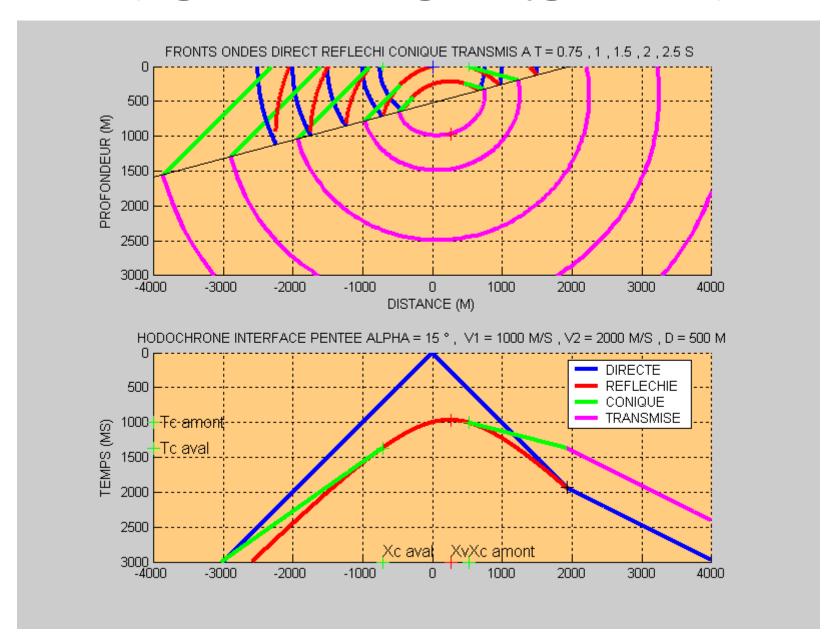
Wave Propagation according to Huygens Principle



Wave Propagation according to Huygens Principle

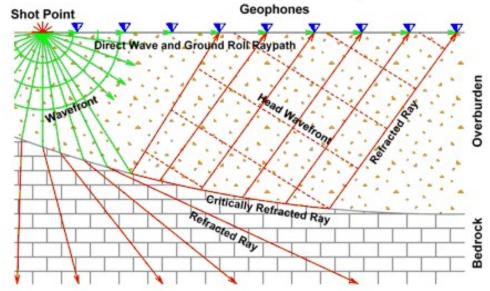


Wave Propagation according to Huygens Principle

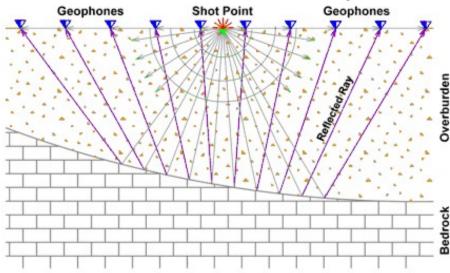


Seismic Method comparison

Seismic Refraction Geometry

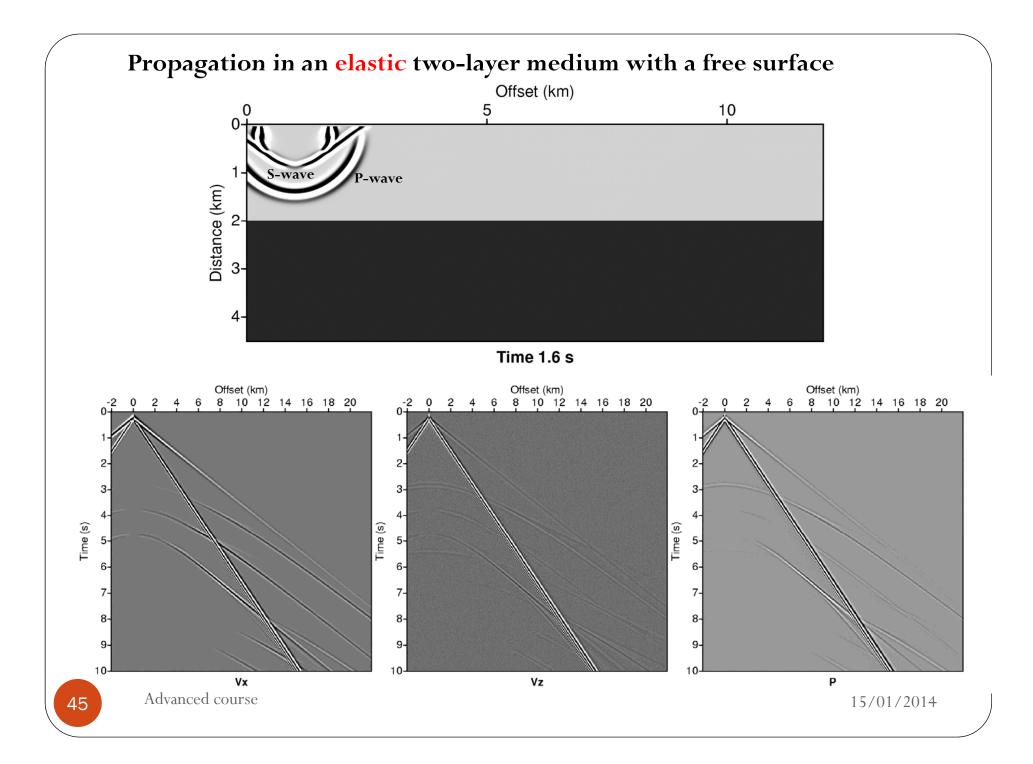


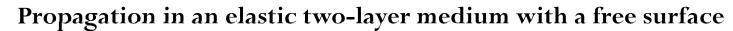
Seismic Reflection Geometry

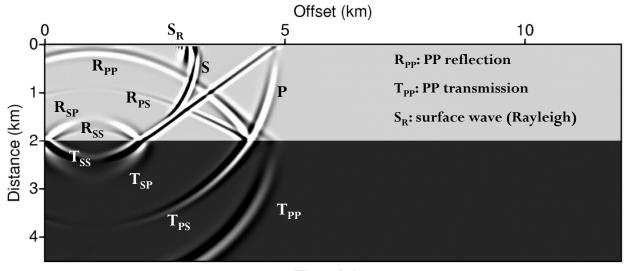


Seismic Method comparison

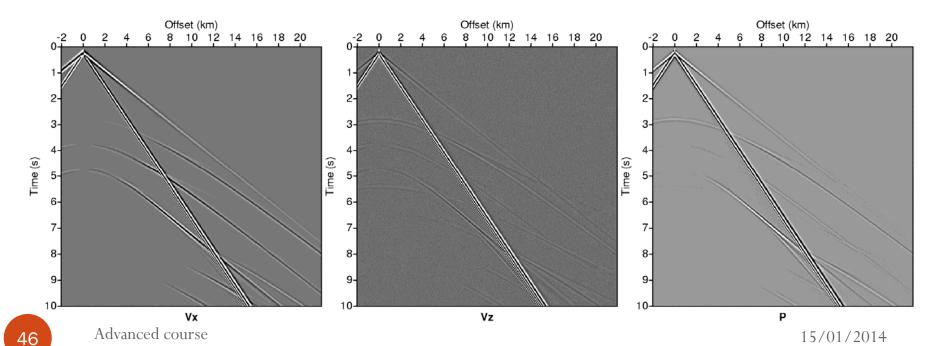
	Refraction	Reflection
Typical targets	Near-horizontal density contrasts at depths less than ~100 feet	Horizontal to dipping density contrasts, and laterally restricted targets such as cavities or tunnels at depths greater than ~50 feet
Required Site Conditions	Accessible dimensions greater than ~5x the depth of interest; unpaved greatly preferred	None
Vertical Resolution	10 to 20 percent of depth	5 to 10 percent of depth
Lateral Resolution	~1/2 the geophone spacing	~1/2 the geophone spacing
Effective Practical Survey Depth	1/5 to 1/4 the maximum shot-geophone separation	>50 feet
Relative Costs	N	3N-5N

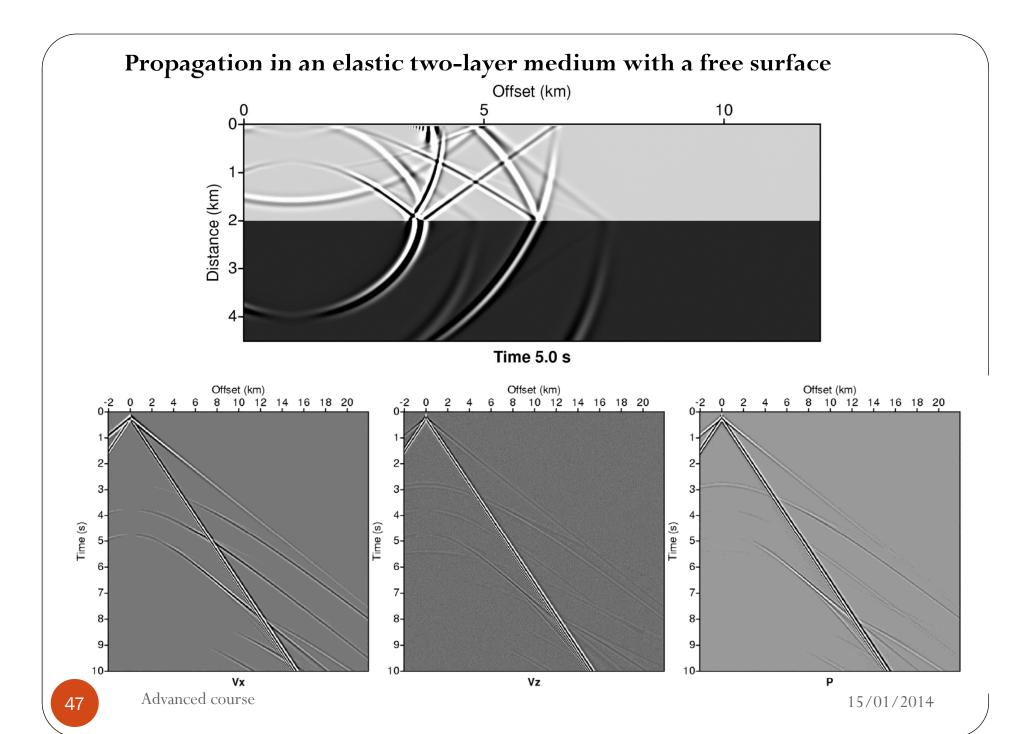


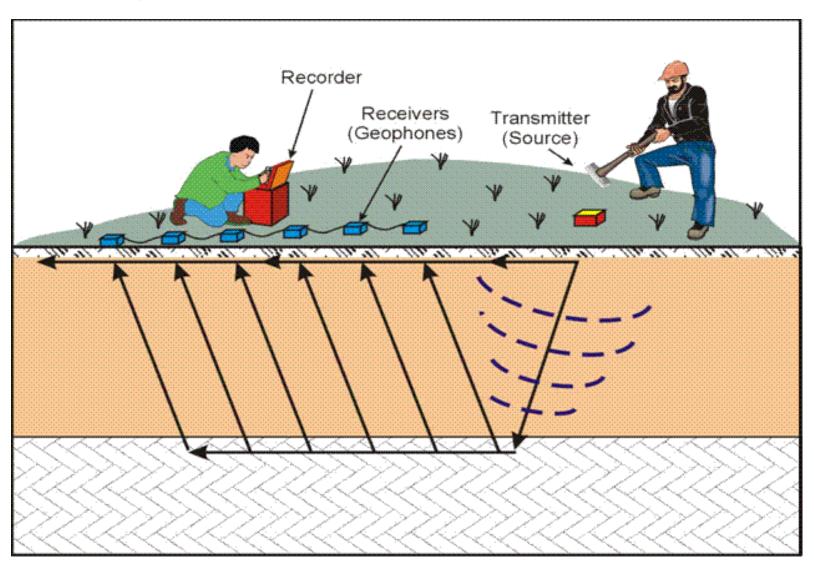




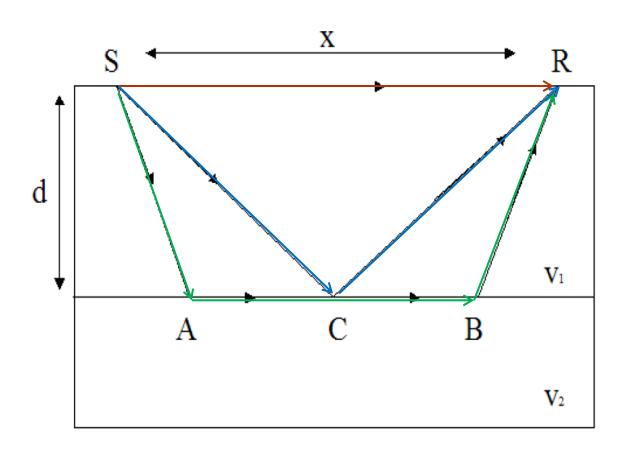
Time 3.6 s







Energy from the source can reach the receiver via different paths



Direct wave

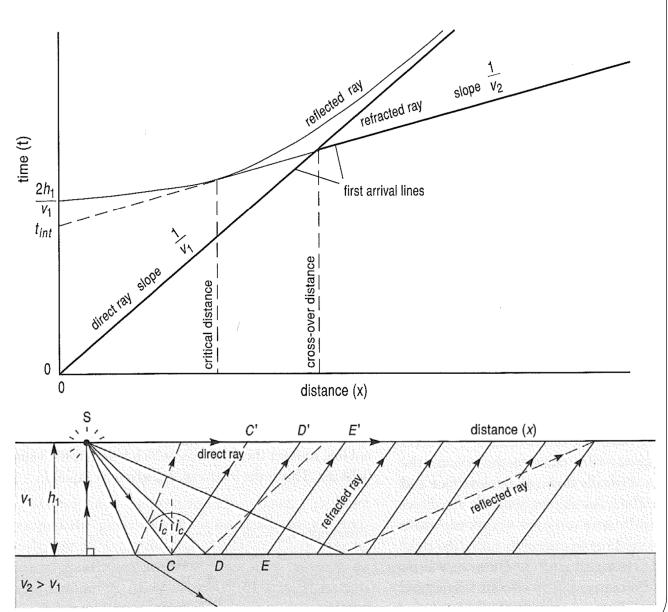
Reflected wave

Head wave or Refracted wave

Time-Distance Diagram (Travel Time curves)

Think about:

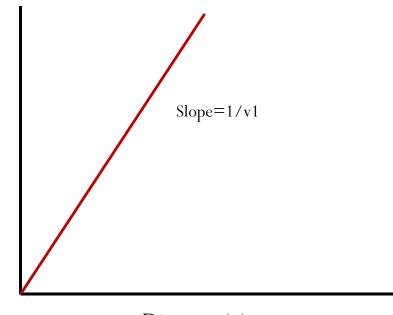
- What would a fast velocity look like on this plot?
- Why is the direct ray a straight line?
- Why must the direct ray plot start at the origin (0,0)?
- Why is the refracted ray a straight line?
- Why does the refracted ray not start at the origin?
- Why does the reflected ray start at origin?
- Why is the reflected ray asymptotic with the direct ray?



1. Direct wave

Energy travelling through the top layer, traveltime

The travel-time curve for the direct wave is simply a linear function of the seismic velocity and the shot-point to receiver distance

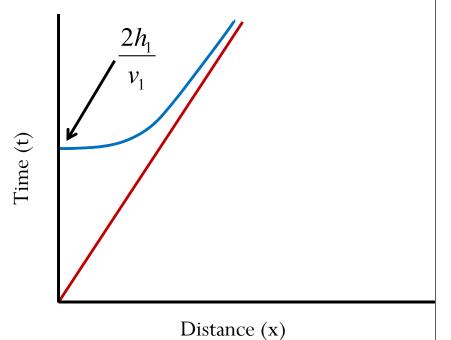


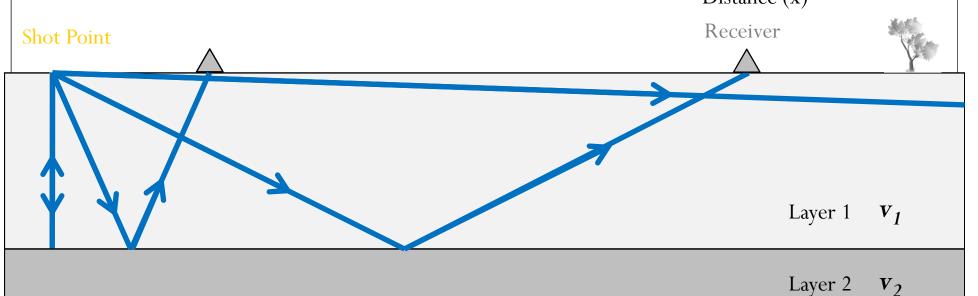
Distance (x)



Time (t)

- 1. Direct wave
- 2. Reflected wave
- -Energy reflecting off the velocity interface.
- -As the angles of incidence and reflection are equal, the wave reflects halfway between source and receiver.
- -The reflected ray arrival time is never a first arrival.





2. Reflected wave

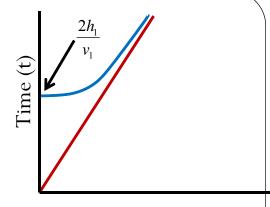
The travel time curve can be found by noting that x/2 and h0 form two sides of a right triangle, so

$$T_R(x) = \frac{2\sqrt{\left(\frac{x}{2}\right)^2 + h_1^2}}{v_1}$$

This curve is a hyperbola, it can be written as

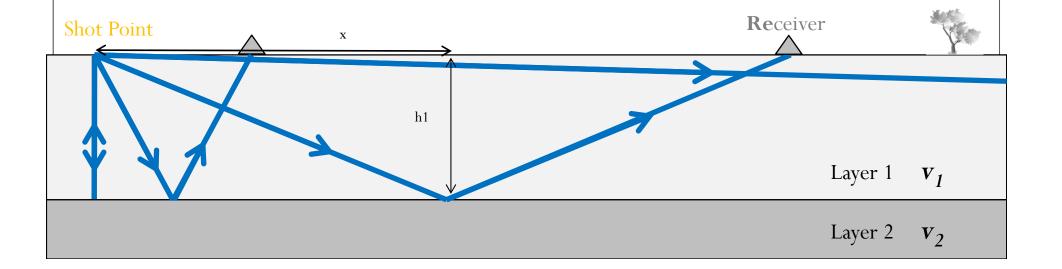
$$T_R^2(x) = \frac{x^2}{v_1^2} + 4\frac{h_1^2}{v_1^2}$$

For x = 0 the reflected wave goes straight up and down, with a travel time of TR(0) = 2h1/v1. At distances much greater than the layer thickness (x >> h), the travel time for the reflected wave asymptotically approaches that of the direct wave.

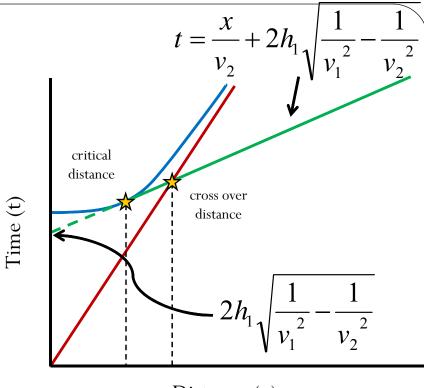


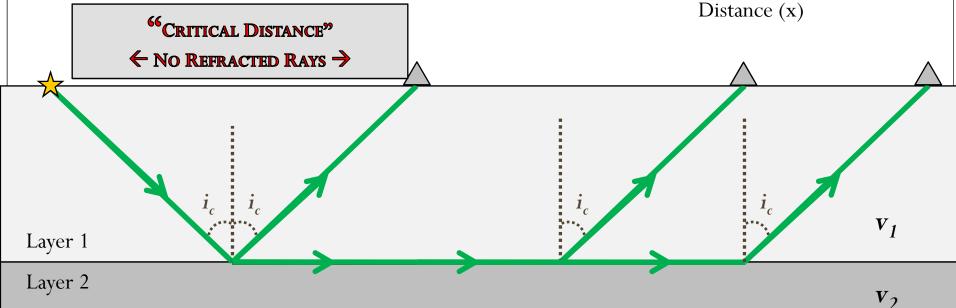
Distance (x)

66 INTERCEPT TIME?
GIVES LAYER THICKNESS



- 1. Direct wave
- 2. Reflected wave
- 3. Head wave or Refracted wave
- -Energy refracting across the interface.
- -Only arrives after critical distance.
- Is first arrival only after **cross over distance**





3. Head wave or Refracted wave

The travel time can be computed by assuming that the wave travels down to the interface such that it impinges at critical angle, then travels just below the interface with the velocity of the lower medium, and finally leaves the interface at the critical angle and travels upwards to the surface.

$$T_h(x) = \frac{AB}{V1} + \frac{BC}{V2} + \frac{CD}{V1}$$

Show that:

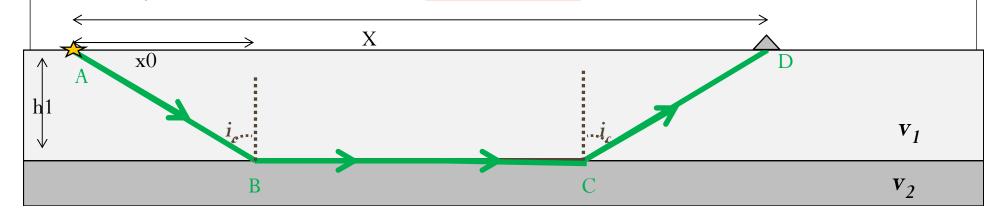
$$T_h(x) = \frac{x}{V2} + \frac{2h1\cos{(ic)}}{V1}$$

Do it many times yourself!

$$\sin(ic) = \frac{V1}{V2}$$

$$\tan = \frac{\sin}{\cos}$$

$$\cos^2 + \sin^2 = 1$$



3. Head wave or Refracted wave

The axis *intercept time* is found by projecting the travel time curve back to x = 0. The intercept time allows a depth estimation.

$$\tau = 2h_1 \sqrt{\left(\frac{1}{v_1}\right)^2 - \left(\frac{1}{v_2}\right)^2}$$

Critical distance xc: distance beyond which critical incidence first occurs.

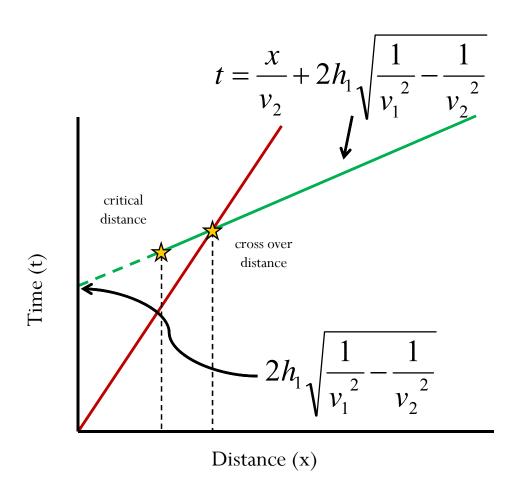
$$x_c = 2h_1 \tan(i_c)$$

At the critical distance the direct wave arrives before the head wave. At some point, however, the travel time curves cross, and beyond this point the head wave is the first arrival. The *crossover distance*, xd, where this occurs, is found by setting TD(x) = TH(x), which yields:

$$x_d = 2h_1 \sqrt{\frac{v_2 + v_1}{v_2 - v_1}}$$

The crossover distance is of interest to determine the length of the refraction line.

Travel-time for refracted waves



Reminder: $\sin(ic) = \frac{\alpha 1}{\alpha 2}$

Note on Refraction angle

Interesting to notice that the higher the velocity contrast, the smaller the refraction angle.

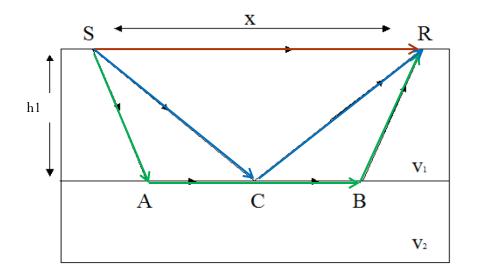
$$V1 = 1000 \text{ m/s}$$
 $\lambda = 11 ^{\circ}$ $V2 = 5000 \text{ m/s}$

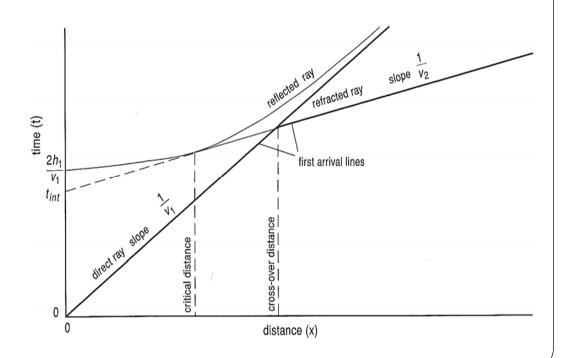
$$V1 = 1000 \text{ m/s}$$
 $\lambda = 30 ^{\circ}$ $V2 = 2000 \text{ m/s}$

=> We can only analyse cases with an increasing velocity function with depth

Summary

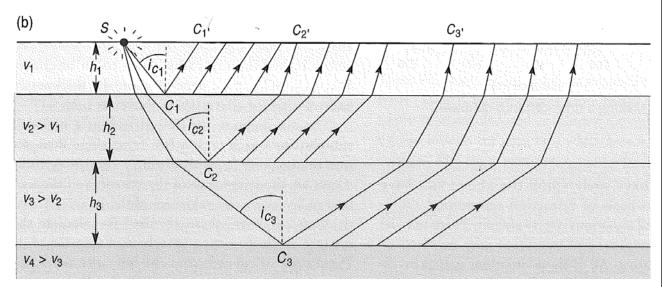
- v1 determined from the slope of the direct arrival (straight line passing through the origin)
- v2 determined from the slope of the head wave (straight line first arrival beyond the critical distance)
- Layer thickness h1 determined from the intercept time of the head wave (already knowing v1 and v2)

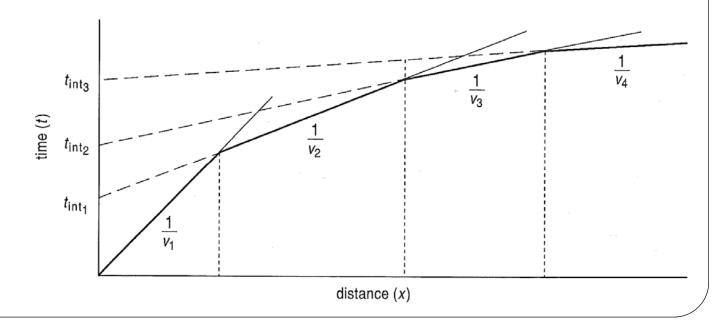




Multiple-layers

For multiple layered models we can apply the same process to determine layer thickness and velocity sequentially from the top layer to the bottom.

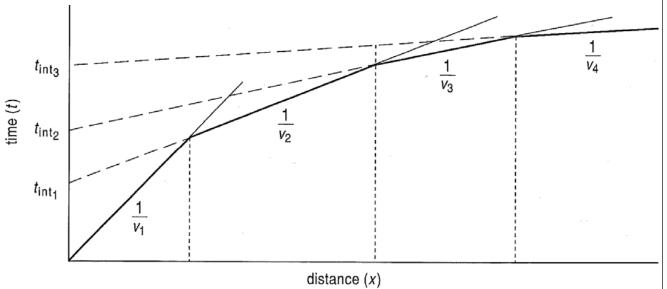




Multiple-layers

- The layer thicknesses are not as easy to find
- Recall...

$$t = \frac{x}{v_1} + \frac{2h_1 \cos i_c}{v_1}$$



$$t_{\text{int}_1} = \frac{2h_1 \cos i_{c_1}}{v_1}$$

Solve for h1...

$$h_1 = \frac{v_1 t_{\text{int}_1}}{2\cos i_{c_1}}$$

Now, plug in h1 and solve the remaining layers one at a time ...

$$t_{\text{int}_2} = \frac{2h_1 \cos i_{c_1}}{v_1} + \frac{2h_2 \cos i_{c_2}}{v_2}$$

BEWARE!!! h_1 , h_2 , are layer thicknesses, not depth to interfaces. So, depth to bottom of layer 3 /top of layer $4 = h_1 + h_2 + h_3$

Multiple-layers

General formulation

$$T_n = \frac{\Delta}{V_n} + \frac{2H_0\cos{(ic)}}{V_0} + 2\sum_{i=1}^{n-1} \frac{H_i\cos{(ic_{i+1})}}{V_1}$$

Home works for those interested in mathematical manipulations